

#### Features

- ☐ High-density 8 megabit Static RAM module)
- ☐ Low profile 72-lead SIMM and Angled SIMM (Single In-line Memory Module)
- ☐ Very fast access time: 10 ns (max.)
- ☐ Surface mounted plastic components on an epoxy laminate (FR-4) substrate
- ☐ Single 5V ( $\pm 10\%$ ) power supply
- ☐ Multiple  $V_{SS}$  pins and decoupling capacitors for maximum noise immunity
- ☐ Inputs/outputs directly TTL compatible

#### Description

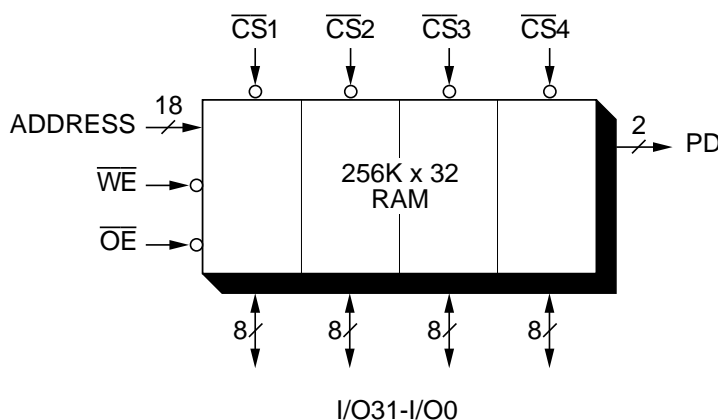
The PDM4M4060 is a 256K x 32 static RAM module constructed on an epoxy laminate (FR-4) substrate using eight 256K x 4 static RAMs in plastic SOJ packages. Availability of four chip select lines (one for each of two RAMs) provides byte access. The PDM4M4060 is available with access times as fast as 15 ns with minimal power consumption.

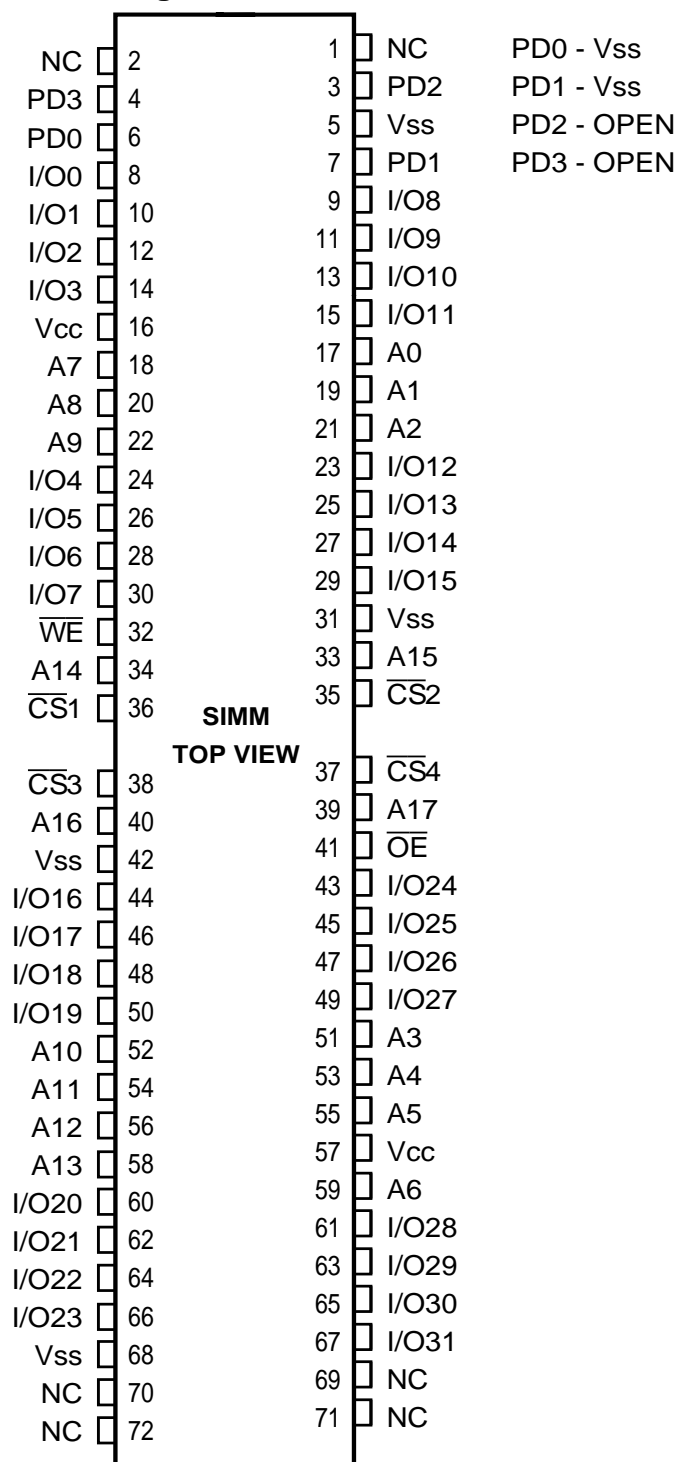
The PDM4M4060 is packaged in a 72-lead SIMM (Single In-line Memory Module). The SIMM configuration allows 72 leads to be placed on a package 4.25" long and 0.35" wide. At only 0.650" high, this low-profile package is ideal for systems with minimum board spacing. The SIMM configuration allows use of angled sockets to reduce the effective module height further. The Angled SIMM configuration allows 72 leads to be placed on a package 4.255" long and 0.35" wide. At only 0.680" high, this low-profile package is ideal for systems with minimum board spacing.

All inputs and outputs of the PDM4M4060 are TTL compatible and operate from a single 5V supply. Full asynchronous circuitry requires no clock or refresh for operation and provides equal access and cycle times for ease of use.

Four identification pins (PD3-PD0) are provided for applications in which different density versions of the module are used. In this way, the target system can read the respective levels of PD3-PD0 to determine a 256K depth.

#### Functional Block Diagram



Pin Configuration<sup>(1)</sup>

## Pin Assignment

| Pin        | Signal               |
|------------|----------------------|
| I/O31-I/O0 | Data Inputs/Outputs  |
| A17-A0     | Addresses            |
| CS4-CS1    | Chip Selects         |
| WE         | Write Enable         |
| OE         | Output Enable        |
| PD3-PD0    | Depth Identification |
| Vcc        | Power                |
| Vss        | Ground               |
| NC         | No Connect           |

NOTE: 1. Pins 3, 4, 5, and 7 (PD3-PD0) are read by the user to determine the density of the module. If PD0, PD1 reads V<sub>SS</sub> and PD2, PD3 reads OPEN then the module has a 256K depth.

**Truth Table**

| Mode                    | $\overline{CS}$ | $\overline{OE}$ | $\overline{WE}$ | Output              | Power   |
|-------------------------|-----------------|-----------------|-----------------|---------------------|---------|
| Deselect/<br>Power-down | H               | X               | X               | High-Z              | Standby |
| Read                    | L               | L               | H               | DATA <sub>OUT</sub> | Active  |
| Write                   | L               | X               | L               | DATA <sub>IN</sub>  | Active  |
| Deselect                | L               | H               | H               | High-Z              | Active  |

**Absolute Maximum Ratings<sup>(1)</sup>**

| Symbol            | Rating   | Com'l.       | Ind.         | Unit |
|-------------------|--|--------------|--------------|------|
| V <sub>TERM</sub> | Terminal Voltage with Respect to V <sub>SS</sub> | −0.5 to +7.0 | −0.5 to +7.0 | V    |
| T <sub>BIAS</sub> | Temperature Under Bias                           | −10 to +85   | −10 to +85   | °C   |
| T <sub>STG</sub>  | Storage Temperature                              | −55 to +125  | −65 to +150  | °C   |
| T <sub>A</sub>    | Operating Temperature                            | 0 to +70     | 0 to +70     | °C   |
| P <sub>T</sub>    | Power Dissipation                                | 1.0          | 1.0          | W    |
| I <sub>OUT</sub>  | DC Output Current                                | 50           | 50           | mA   |

NOTE: 1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

**Recommended DC Operating Conditions**

| Symbol          | Parameter           | Min. | Typ. | Max. | Unit |
|-----------------|---------------------|------|------|------|------|
| V <sub>CC</sub> | Supply Voltage      | 4.75 | 5.0  | 5.25 | V    |
| V <sub>SS</sub> | Supply Voltage      | 0    | 0    | 0    | V    |
| Commercial      | Ambient Temperature | 0    | 25   | 70   | °C   |

**DC Electrical Characteristics** ( $V_{CC} = 5.0V \pm 5\%$ ,  $T_A = 0^\circ C$  to  $70^\circ C$ )

| Symbol   | Parameter  | Test Conditions   | Min.         | Max. | Unit    |
|----------|--|---|--------------|------|---------|
| $I_{LI}$ | Input Leakage Current (Address $\overline{WE}$ , and $\overline{OE}$ ) | $V_{CC} = \text{Max.}, V_{IN} = V_{SS} \text{ to } V_{CC}$                          | —            | 80   | $\mu A$ |
| $I_{LI}$ | Input Leakage Current (Data and $\overline{CS}$ )                      | $V_{CC} = \text{Max.}, V_{IN} = V_{SS} \text{ to } V_{CC}$                          | —            | 10   | $\mu A$ |
| $I_{LO}$ | Output Leakage Current   | $V_{OUT} = V_{SS} \text{ to } V_{CC}, V_{CC} = \text{Max.}, \overline{CS} = V_{IH}$ | —            | 10   | $\mu A$ |
| $V_{OL}$ | Output Low Voltage   | $I_{OL} = 8 \text{ mA}, V_{CC} = \text{Min.}$                                       | —            | 0.4  | V       |
| $V_{OH}$ | Output High Voltage  | $I_{OL} = -4 \text{ mA}, V_{CC} = \text{Min.}$                                      | 2.4          | —    | V       |
| $V_{IH}$ | Input High Voltage   |   | 2.2          | 6.0  | V       |
| $V_{IL}$ | Input Low Voltage  |   | $-0.5^{(1)}$ | 0.8  | V       |

NOTE 1.  $V_{IL} = -3.0V$  for pulse widths less than 10 ns, once per cycle.

**Power Supply Characteristics**

| Symbol    | Parameter  | 10 ns - 15 ns <sup>(1)</sup><br>Max | 20 ns - 25 ns <sup>(1)</sup><br>Max | Unit |
|-----------|--|-------------------------------------|-------------------------------------|------|
| $I_{CC}$  | Operating Current<br>$\overline{CS} = V_{IL}, V_{CC} = \text{Max.}, f = f_{MAX}, \text{Outputs Open}$                                | 1600                                | 1360                                | mA   |
| $I_{SB}$  | Standby Current<br>$\overline{CS} \geq V_{IH}, V_{CC} = \text{Max.}, f = f_{MAX}, \text{Outputs Open}$                               | 480                                 | 480                                 | mA   |
| $I_{SB1}$ | Full Standby Current $\overline{CS} \geq V_{CC} - 0.2V$ ,<br>$f = 0, V_{IN} > V_{CC} - 0.2V \text{ or } < 0.2V, \text{Outputs Open}$ | 320                                 | 120                                 | mA   |

NOTE 1. Preliminary specification only.

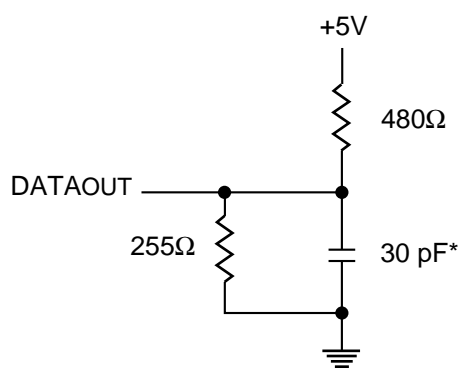
**Capacitance<sup>(1)</sup>** ( $T_A = +25^\circ C, f = 1.0 \text{ MHz}$ )

| Symbol      | Parameter  | Max. | Unit |
|-------------|--|------|------|
| $C_{IN(D)}$ | Input Capacitance, ( $\overline{CS}$ ) $V_{IN} = 0V$   | 20   | pF   |
| $C_{IN(A)}$ | Input Capacitance, (Address and Control) $V_{IN} = 0V$ | 70   | pF   |
| $C_{I/O}$   | I/O Capacitance, $V_{OUT} = 0V$                        | 12   | pF   |

NOTE 1. This parameter is determined by device characteristics but is not production tested.

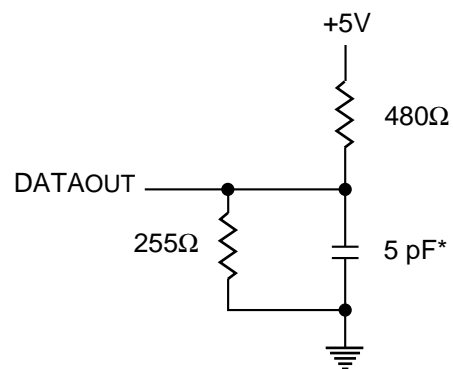
**AC Test Conditions**

|                               |                     |
|-------------------------------|---------------------|
| Input Pulse Levels            | $V_{SS}$ to 3.0V    |
| Input Rise/Fall Times         | 5 ns                |
| Input Timing Reference Levels | 1.5V                |
| Output Reference Levels       | 1.5V                |
| Output Load                   | See Figures 1 and 2 |



\* Including scope and jig capacitances

**Figure 1. Output Load**



\* Including scope and jig capacitances

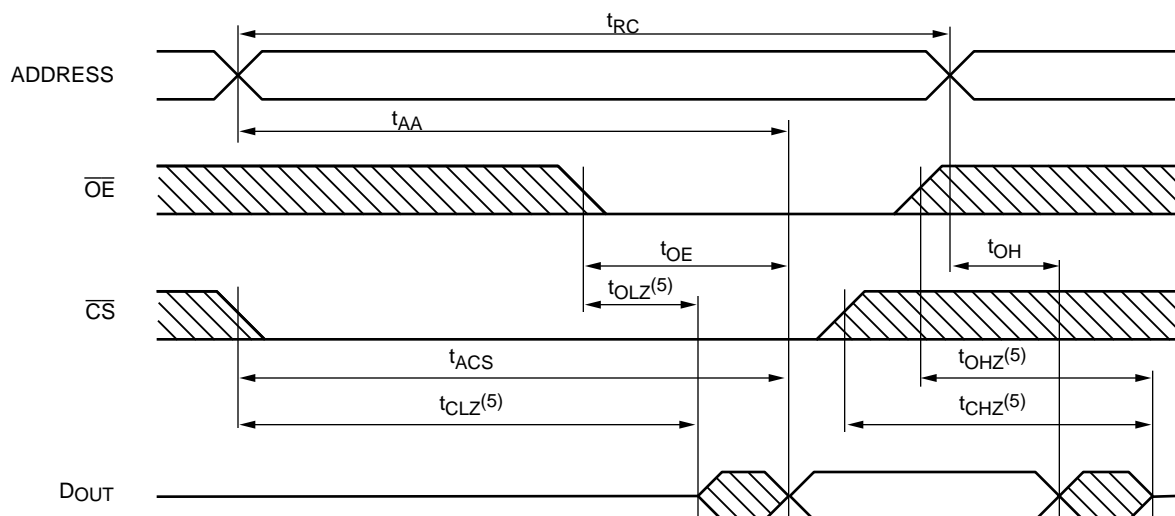
**Figure 2. Output Load**  
(for tOHZ, tCHZ, tOLZ, and tCLZ)

**AC Electrical Characteristics** ( $V_{CC} = 5V \pm 5\%$ ,  $T_A = 0^\circ C$  to  $+70^\circ C$ )

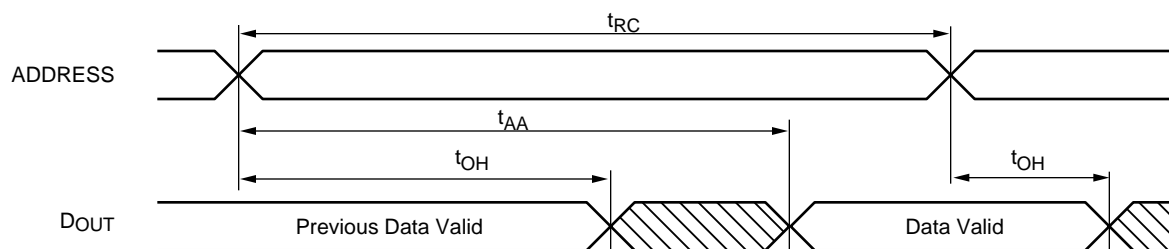
| Symbol                          | Parameter                          | PDM4M4060SXXZ, PDM4M4060SXXM |      |                       |      |                       |      |        |      |        |      | Unit |
|---------------------------------|------------------------------------|------------------------------|------|-----------------------|------|-----------------------|------|--------|------|--------|------|------|
|                                 |                                    | -10 ns <sup>(2)</sup>        |      | -12 ns <sup>(2)</sup> |      | -15 ns <sup>(2)</sup> |      | -20 ns |      | -25 ns |      |      |
|                                 |                                    | Min.                         | Max. | Min.                  | Max. | Min.                  | Max. | Min.   | Max. | Min.   | Max. |      |
| Read Cycle                      |                                    |                              |      |                       |      |                       |      |        |      |        |      |      |
| t <sub>RC</sub>                 | Read Cycle Time                    | 10                           | —    | 12                    | —    | 15                    | —    | 20     | —    | 25     | —    | ns   |
| t <sub>AA</sub>                 | Address Access Time                | —                            | 10   | —                     | 12   | —                     | 15   | —      | 20   | —      | 25   | ns   |
| t <sub>ACS</sub>                | Chip Select Access Time            | —                            | 10   | —                     | 12   | —                     | 15   | —      | 20   | —      | 25   | ns   |
| t <sub>CLZ</sub> <sup>(1)</sup> | Chip Select to Output in Low-Z     | 2                            | —    | 2                     | —    | 2                     | —    | 5      | —    | 5      | —    | ns   |
| t <sub>OE</sub>                 | Output Enable to Output Valid      | —                            | 5    | —                     | 7    | —                     | 8    | —      | 10   | —      | 12   | ns   |
| t <sub>OLZ</sub> <sup>(1)</sup> | Output Enable to Output in Low-Z   | 0                            | —    | 0                     | —    | 0                     | —    | 0      | —    | 0      | —    | ns   |
| t <sub>CHZ</sub> <sup>(1)</sup> | Chip Deselect to Output in High-Z  | —                            | 6    | —                     | 7    | —                     | 8    | —      | 10   | —      | 12   | ns   |
| t <sub>OHZ</sub> <sup>(1)</sup> | Output Disable to Output in High-Z | —                            | 6    | —                     | 7    | —                     | 8    | —      | 10   | —      | 10   | ns   |
| t <sub>OH</sub>                 | Output Hold from Address Change    | 3                            | —    | 3                     | —    | 3                     | —    | 3      | —    | 3      | —    | ns   |
| Write Cycle                     |                                    |                              |      |                       |      |                       |      |        |      |        |      |      |
| t <sub>WC</sub>                 | Write Cycle Time                   | 10                           | —    | 12                    | —    | 15                    | —    | —      | 20   | —      | 25   | ns   |
| t <sub>CW</sub>                 | Chip Select to End of Write        | 8                            | —    | 10                    | —    | 12                    | —    |        |      |        |      | ns   |
| t <sub>AW</sub>                 | Address Valid to End of Write      | 8                            | —    | 10                    | —    | 12                    | —    | 20     | —    | 25     | —    | ns   |
| t <sub>AS</sub>                 | Address Setup Time                 | 0                            | —    | 0                     | —    | 0                     | —    | 15     | —    | 20     | —    | ns   |
| t <sub>WP</sub>                 | Write Pulse Width                  | 8                            | —    | 10                    | —    | 12                    | —    | 15     | —    | 20     | —    | ns   |
| t <sub>WR</sub>                 | Write Recovery Time                | 1                            | —    | 1                     | —    | 1                     | —    | 0      | —    | 0      | —    | ns   |
| t <sub>WHZ</sub> <sup>(1)</sup> | Write Enable to Output in High-Z   | —                            | 5    | —                     | 6    | —                     | 7    | 15     | —    | 20     | —    | ns   |
| t <sub>DW</sub>                 | Data to Write Time Overlap         | 6                            | —    | 7                     | —    | 8                     | —    | 0      | —    | 0      | —    | ns   |
| t <sub>DH</sub>                 | Data Hold from Write Time          | 1                            | —    | 1                     | —    | 1                     | —    | —      | 13   | —      | 15   | ns   |
| t <sub>OW</sub> <sup>(1)</sup>  | Output Active from End of Write    | 1                            | —    | 1                     | —    | 1                     | —    | 12     | —    | 15     | —    | ns   |

- NOTES 1. This parameter is determined by device characteristics but is not production tested.  
 2. Preliminary specifications only.

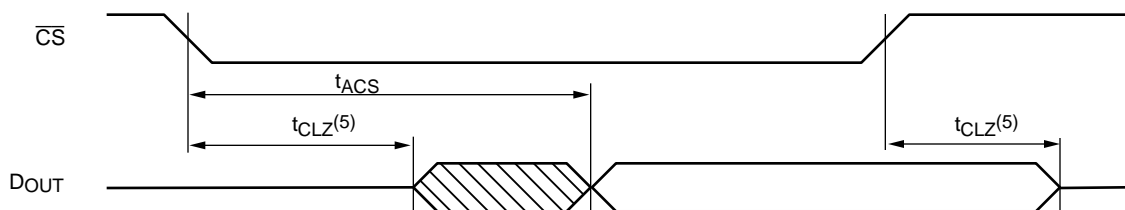
### Timing Waveforms of Read Cycle No.1<sup>(1)</sup>



### Timing Waveforms of Read Cycle No.2<sup>(1,2,4)</sup>

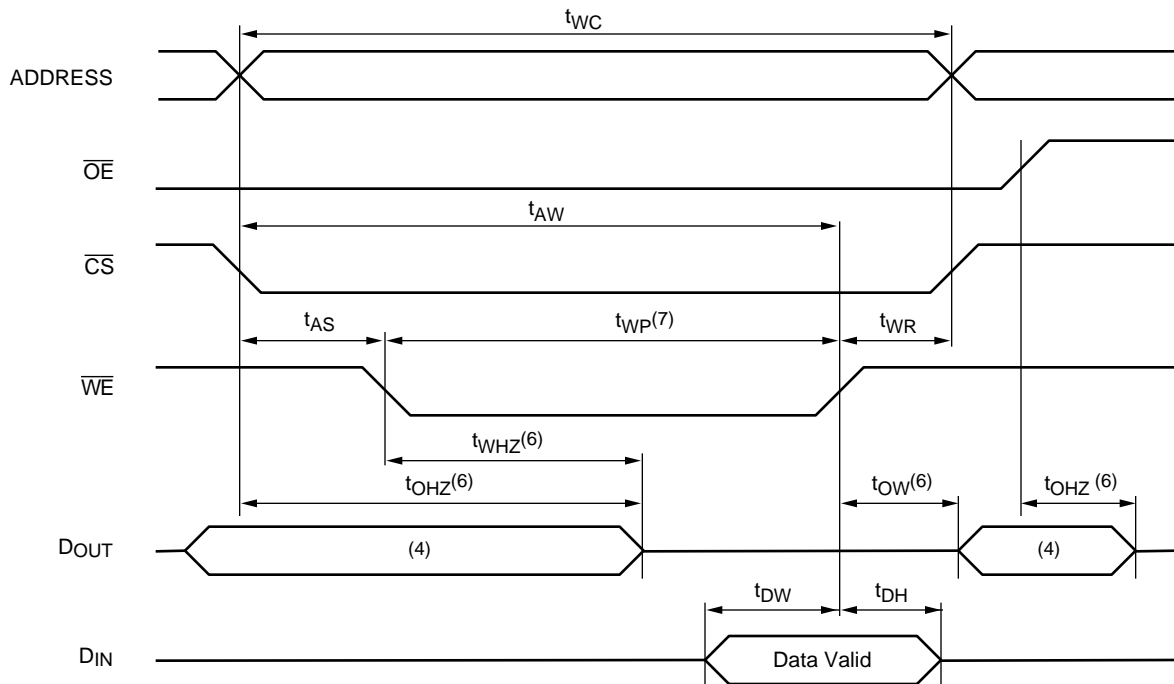


### Timing Waveforms of Read Cycle No.3<sup>(1,3,4)</sup>

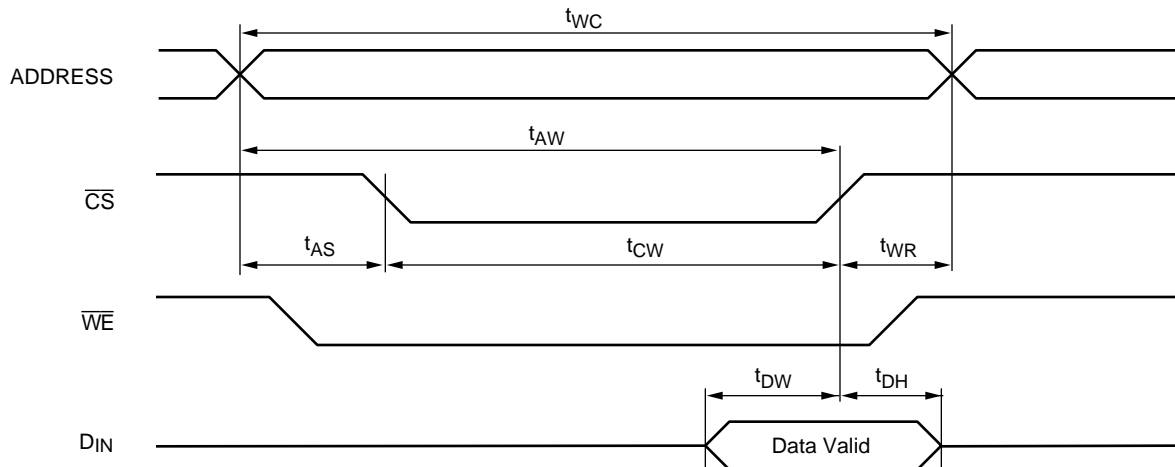


- NOTES
- $\overline{WE}$  is HIGH for Read Cycle.
  - Device is continuously selected.  $\overline{CS} = V_{IL}$ .
  - Address valid prior to or coincident with  $\overline{CS}$  transition LOW.
  - $\overline{OE} = V_{IL}$ .
  - Transition is measured  $\pm 200$  mV for steady state. This parameter is determined by device characteristics but is not production tested.

### Timing Waveforms of Write Cycle No.1 ( $\overline{WE}$ Controlled)<sup>(1,2,3,7)</sup>



### Timing Waveforms of Write Cycle No.2 ( $\overline{CS}$ Controlled)<sup>(1,2,3,5)</sup>

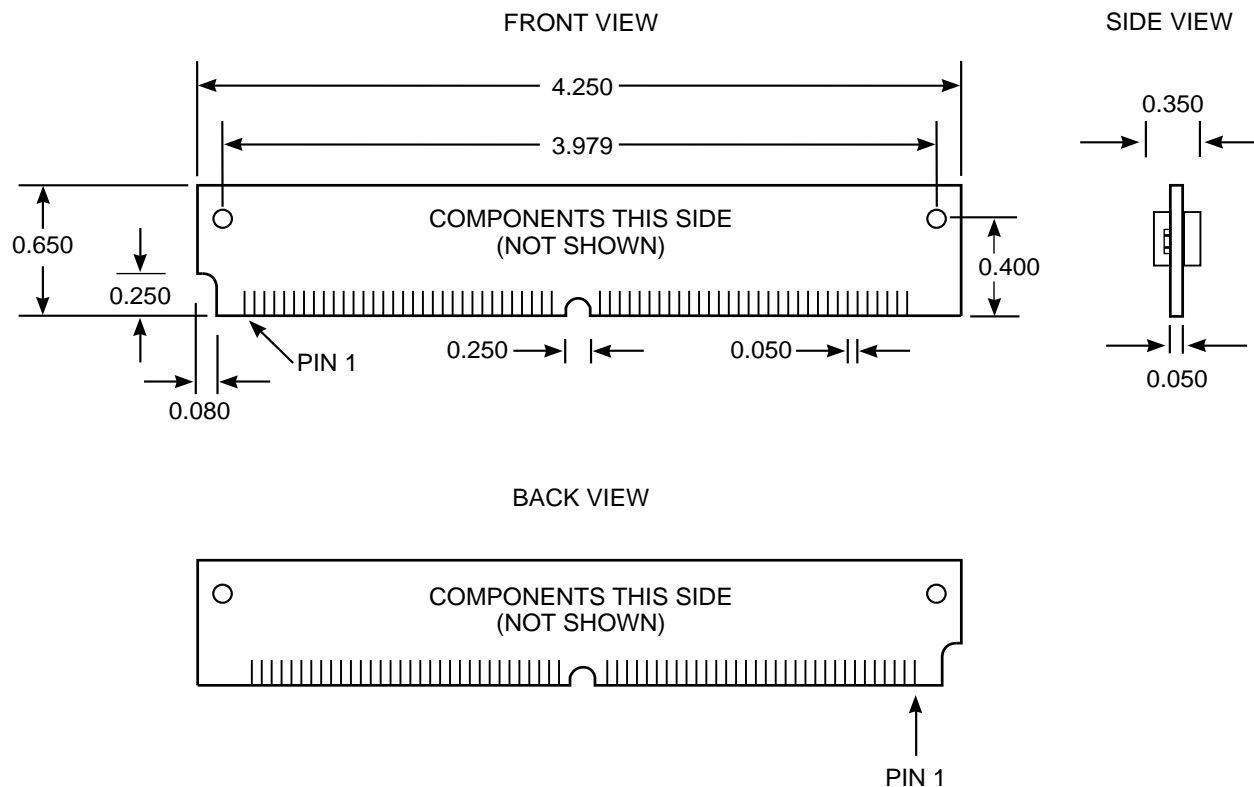


- NOTES
1.  $\overline{WE}$  or  $\overline{CS}$  must be HIGH during all address transitions.
  2. A write occurs during the overlap ( $t_{WP}$ ) of a LOW  $\overline{CS}$  and a LOW  $\overline{WE}$ .
  3.  $t_{WR}$  is measured from the earlier of  $\overline{CS}$  or  $\overline{WE}$  going HIGH to end the write cycle.
  4. During this period, I/O pins are in the output state, and input signals must be applied.
  5. If the  $\overline{CS}$  LOW transition occurs simultaneously with or after the  $\overline{WE}$  LOW transition, the outputs remain in a high-impedance state.
  6. Transition is measured  $\pm 200$  mV for steady state with a 5 pF load (including scope and jig). This parameter is determined by device characteristics but is not production tested.
  7. If  $\overline{OE}$  is LOW during a  $\overline{WE}$  controlled write cycle, the write pulse width must be the larger of  $t_{WP}$  or ( $t_{WHZ} + t_{DW}$ ) to allow the I/O drivers to turn off and data to be placed on the bus for the required  $t_{DW}$ . If  $\overline{OE}$  is HIGH during a  $\overline{WE}$  controlled write cycle, this requirement does not apply and the write pulse width can be as short as the specified  $t_{WP}$ .

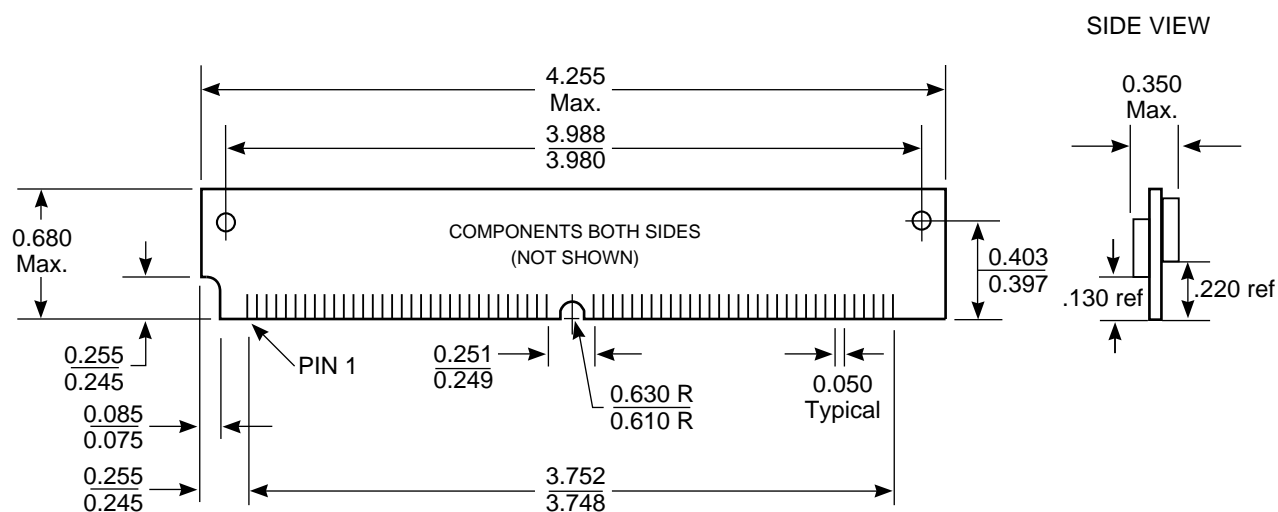


## Package Dimensions

## SIMM Version



## Angled SIMM Version



Ordering Information

